



TBA 331

LINEAR INTEGRATED CIRCUIT

GENERAL PURPOSE TRANSISTOR ARRAY

The TBA 331 is an array of 5 monolithic NPN transistors in a 14-lead dual in-line plastic package. Two transistors are internally connected to form a differential amplifier.

The transistors of the TBA 331 are well suited to low noise general purpose and to a wide variety of applications in low power systems in the DC through VHF range. They may be used as discrete components in conventional circuits; in addition, they provide the very significant inherent integrated circuit advantages of close electrical and thermal matching.

ABSOLUTE MAXIMUM RATINGS

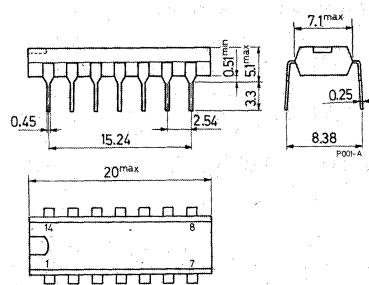
		Each transistor	Total package
V_{CBO}	Collector-base voltage ($I_E = 0$)	20	— V
V_{CEO}	Collector-emitter voltage ($I_B = 0$)	15	— V
V_{CSS}^*	Collector-substrate voltage	20	— V
V_{EBO}	Emitter-base voltage ($I_C = 0$)	5	— V
I_C	Collector current	50	— mA
P_{tot}	Total power dissipation at $T_{amb} \leq 55^\circ\text{C}$	300	750 mW
T_{stg}, T_j	Storage and junction temperature	-40 to 150	$^\circ\text{C}$
T_{op}	Operating temperature	0 to 85	$^\circ\text{C}$

* The collector of each transistor of the TBA 331 is isolated from the substrate by an integrated diode. The substrate (pin 13) must be connected to the most negative point in the external circuit to maintain isolation between transistors and to provide for normal transistor action.

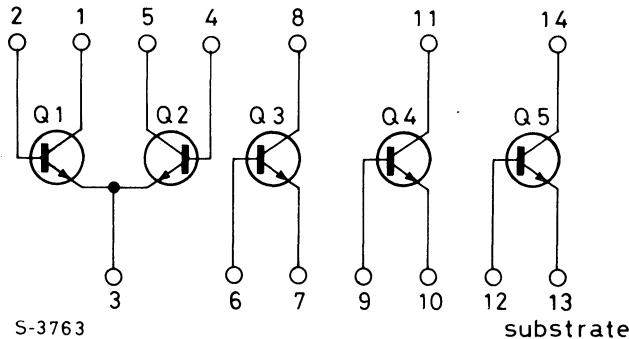
ORDERING NUMBER: TBA 331

MECHANICAL DATA

Dimensions in mm



SCHEMATIC DIAGRAM



THERMAL DATA

$R_{th\ j-amb}$ Thermal resistance junction-ambient max 315°C/W 126°C/W

ELECTRICAL CHARACTERISTICS ($T_{amb} = 25^\circ\text{C}$ unless otherwise specified)

Parameter		Test conditions	Min.	Typ.	Max.	Unit	Fig.
I _{CBO}	Collector cutoff current ($I_E = 0$)	V _{CB} = 10 V		0.002	40	nA	1
I _{CEO}	Collector cutoff current ($I_B = 0$)	V _{CE} = 10 V		see curve	0.5	μA	2
I _{B1} -I _{B2}	Input offset current	I _C = 1 mA V _{CE} = 3 V		0.3	2	μA	7



ELECTRICAL CHARACTERISTICS (continued)

Parameter	Test conditions	Min.	Typ.	Max.	Unit	Fig.
V_{CBO} Collector-base voltage ($I_E = 0$)	$I_C = 10 \mu A$	20	60		V	—
V_{CEO} Collector-emitter voltage ($I_B = 0$)	$I_C = 1 mA$	15	24		V	—
V_{CSS} collector-substrate voltage ($I_{CSS} = 0$)	$I_C = 10 \mu A$	20	60		V	—
$V_{CE(\text{sat})}$ Collector-emitter saturation voltage	$I_B = 1 mA$ $I_C = 10 mA$		0.23		V	—
V_{EBO} Emitter-base voltage ($I_C = 0$)	$I_E = 10 \mu A$	5	7		V	—
V_{BE} Base-emitter voltage	$I_E = 1 mA$ $V_{CE} = 3 V$ $I_E = 10 mA$ $V_{CE} = 3 V$		0.715		V	4
$ V_{BE1}-V_{BE2} $ Input offset voltage	$I_C = 1 mA$ $V_{CE} = 3 V$		0.45	5	mV	4-6
$ V_{BE3}-V_{BE4} $ Input offset voltage	$I_C = 1 mA$ $V_{CE} = 3 V$		0.45	5	mV	4-6
$ V_{BE4}-V_{BE5} $ Input offset voltage	$I_C = 1 mA$ $V_{CE} = 3 V$		0.45	5	mV	4-6
$ V_{BE5}-V_{BE4} $ Input offset voltage	$I_C = 1 mA$ $V_{CE} = 3 V$		0.45	5	mV	4-6
ΔV_{BE} ΔT Base-emitter voltage temperature coefficient	$I_C = 1 mA$ $V_{CE} = 3 V$		-1.9		$mV/\text{ }^\circ C$	5
$ V_{BE1}-V_{BE2} $ ΔT Input offset voltage temperature coefficient	$I_C = 1 mA$ $V_{CE} = 3 V$		1.1		$\mu V/\text{ }^\circ C$	6

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ELECTRICAL CHARACTERISTICS (continued)

Parameter	Test conditions	Min.	Typ.	Max.	Unit.	Fig.
h_{FE} DC current gain	$I_C = 10 \text{ mA}$ $V_{CE} = 3 \text{ V}$		100		—	3
	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$	40	100		—	3
	$I_C = 10 \mu\text{A}$ $V_{CE} = 3 \text{ V}$		54		—	3
f_T Transition frequency	$I_C = 3 \text{ mA}$ $V_{CE} = 3 \text{ V}$	300	550		MHz	14
NF Noise figure	$I_C = 100 \mu\text{A}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ KHz}$ $R_g = 1 \text{ k}\Omega$		3.25		dB	8
H_{ie} Input impedance	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ kHz}$		3.5		$\text{k}\Omega$	9
h_{fe} Forward current transfer ratio	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ kHz}$		110		—	9
h_{re} Reverse voltage transfer ratio	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ kHz}$		1.8×10^{-4}		—	9
h_{oe} Output admittance	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ kHz}$		15.6		μs	9
y_{ie} Input admittance	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ MHz}$		$0.3 + j0.04$		mS	11
y_{fe} Forward transadmittance	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ MHz}$		$31 - j1.5$		mS	10
y_{re} Reverse transadmittance	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ MHz}$		see curve		mS	13

ELECTRICAL CHARACTERISTICS (continued)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit.	Fig.
y_{ce} Output admittance	$I_C = 1 \text{ mA}$ $V_{CE} = 3 \text{ V}$ $f = 1 \text{ MHz}$			$0.001 + j0.03$	mS	12
C_{EBO} Emitter-base capacitance	$I_C = 0$ $V_{EB} = 3 \text{ V}$		0.6		pF	—
C_{CBO} Collector-base capacitance	$I_E = 0$ $V_{CB} = 3 \text{ V}$		0.58		pF	—
C_{CSS} Collector-substrate capacitance	$I_C = 0$ $V_{CSS} = 3 \text{ V}$		2.8		pF	—

Fig. 1 - Collector cutoff current vs ambient temperature

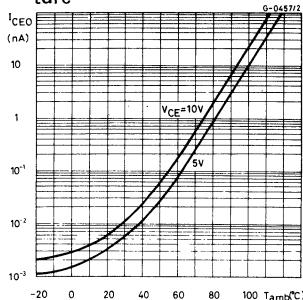


Fig. 4 - Input characteristic for each transistor

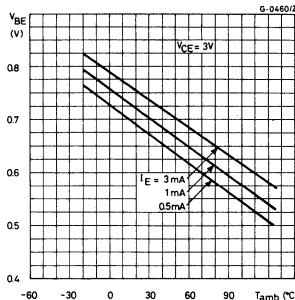


Fig. 2 - DC current gain vs. emitter current.

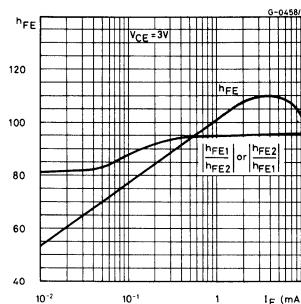


Fig. 5 - Input offset voltage vs. ambient temperature

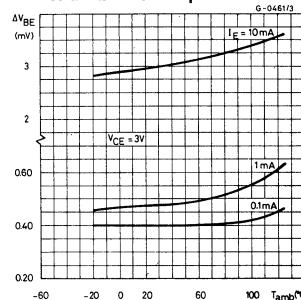


Fig. 3 - Input voltage and input offset voltage vs. emitter current

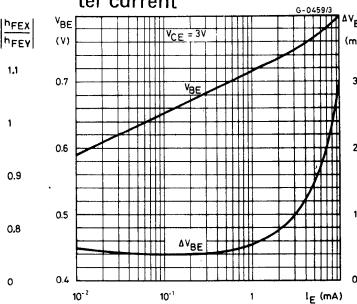
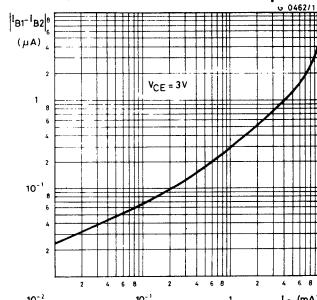
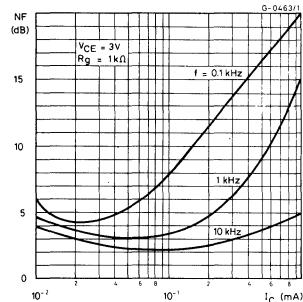
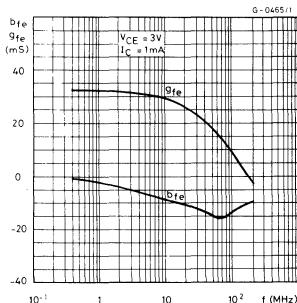
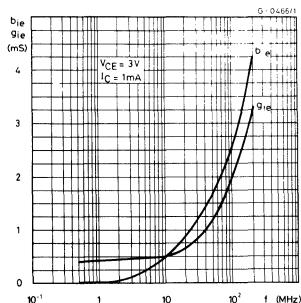
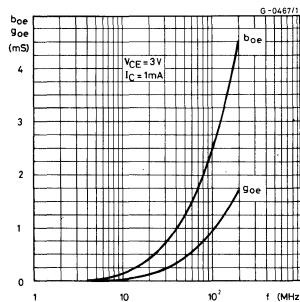
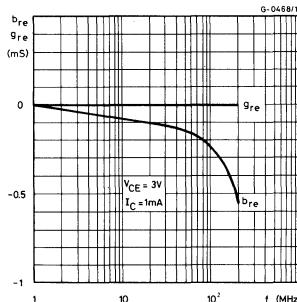


Fig. 6 - Input offset current for matched transistor pair



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